

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Rev. 2-32) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. KIK01 P-322A	SERIAL NO.
	APPLICANT(S) Kenichiro Kobayashi et al.	
	FILING DATE	GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPRO- PRIATE
XS	5 3 4 3 2 8 7	08/30/1994	Wilkins			
I	4 6 2 1 0 6 3	11/04/1986	Wyatt et al.			
	4 7 9 4 3 8 4	12/27/1988	Jackson			
XS	5 6 3 3 7 1 4	05/27/1997	Nyyssonen			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLA- TION
						Y N
XS	DE 19 7 3 9 6 79 A1	10/1998	Germany			
I	2 7 0 1 7 6 2	08/1994	France			
	DE 19 8 1 7 6 64 A1	11/1999	Germany			
	DE 19 9 0 9 2 35 A1	09/1999	Germany			
XS	DE 19 6 2 0 4 19 A1	11/1997	Germany			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	
XS	U.S. Patent Application Publication 2002/0080264, publication date June 27, 2002 entitled METHOD AND APPARATUS FOR DIRECT IMAGE PICK-UP OF GRANULAR SPECK PATTERN GENERATED BY REFLECTING LIGHT OF LASER BEAM

EXAMINER <i>Ming Li</i>	DATE CONSIDERED <i>03/03/05 06/25/06</i>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	